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CAPACITOR FILTERS, L-TYPE, FEEDTHROUGH, ELECTROMAGNETIC INTERFERENCE SUPPRESSION, HERMETICALLY SEALED, BASED ON TYPE SFL100 ESCC Detail Specification No. 3008/029

ISSUE 1 October 2002





ESCC Detail Specification

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CAPACITOR FILTERS, L-TYPE, FEEDTHROUGH, ELECTROMAGNETIC INTERFERENCE SUPPRESSION, HERMETICALLY SEALED, BASED ON TYPE SFL100 ESA/SCC Detail Specification No. 3008/029



space components coordination group

		Approved by					
Issue/Rev.	Date	SCCG Chairman	ESA Director General or his Deputy				
Issue 1	June 1996	Sa mill	Hoons				
Revision 'A'	April 1997	Sa mit	Hom				
Revision 'B'	September 1998	\$a_mill	pp Rasshi				



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DOCUMENTATION CHANGE NOTICE

Rev. Letter	Rev. Date	Reference	CHANGE Item	Approved DCR No.
'A'	Apr. '97	P1. Cover page P2. DCN P6. Table 1(a) P8. Figure 2	 For Variants 04, 16, 28, 40, value under 100kHz corrected For Variants 07, 19, 31, 43, value under 100MHz corrected For Variants 09, 21, 33, 45, value under 1.0MHz and 1.0GHz corrected ∅H Max corrected for Case Size 2 	None None 221384 221384 221384 221384
'B'	Sept. '98	P1. Cover page P2. DCN P13. Table 3	: No. 3, Test Conditions amended : Notes, new Note 4 added	None None 221484 221484



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1. GENERAL

1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, test and inspection data for a Capacitor Filter, L-Type, Feedthrough, Electromagnetic Interference Suppression, Hermetically Sealed, based on Type SFL100. It shall be read in conjunction with ESA/SCC Generic Specification No. 3008, the requirements of which are supplemented herein.

1.2 <u>COMPONENT TYPE VARIANTS</u>

Variants of the basic type capacitor filters specified herein, which are also covered by this specification are given in Table 1(a).

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the capacitor filters specified herein, are as scheduled in Table 1(b).

1.4 PARAMETER DERATING INFORMATION

The parameter derating information applicable to the capacitor filters specified herein, is shown in Figure 1.

1.5 PHYSICAL DIMENSIONS

The physical dimensions of the capacitor filters specified herein, are shown in Figure 2.

1.6 FUNCTIONAL DIAGRAM

The functional diagram, showing lead identification, of the capacitor filters specified herein, is shown in Figure 3.

2. APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:

- (a) ESA/SCC Generic Specification No. 3008 for Capacitors and Capacitor Filters, Feedthrough.
- (b) MIL-STD-202, Test Methods for Electronic and Electrical Component Parts.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply. In addition, the following abbreviations are used:-

 V_T = Test Voltage.



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TABLE 1(a) - TYPE VARIANTS

(12) Inductor Position IN/OUT	(Note Z)	0	0		0		0	0	_	0	_	0	0
(11) Weight	(6)	4.0	8.0	8.0	5.5	8.0	5.5	4.0	8.0	4.0	8.0	8.0	4.0
(10) Case Size (Note 1)		1	2	2	က	2	က	4	2	-	2	2	1
(6)	1.0GHz	20	70	70	70	20	70	02	20	57	70	20	70
Insertion Loss (dB) With full Rated Current applied	100MHz	20	70	70	09	70	09	58	70	40	55	70	65
Insertion Loss (dB) ull Rated Current a	10MHz	09	09	55	20	65	50	45	55	25	45	09	90
Inser Vith full Ra	1.0MHz	40	44	38	32	45	30	24	44	7.0	25	44	44
Λ	100kHz	20	26	19	10	20	12	5.0	26	t	0.9	25	26
(8) Capacitance C	(JnF)	0.8	1.6	0.656	0.312	0.80	0.264	0.120	1.6	0.0176	0.144	1.2	1.2
(7) Rated Current I _R	(A)	15	10	5.0	15	15	15	15	10	15	10	10	15
(6) d.c. Resist. Rs	(mΩ)	4.0	10	15	8.0	10	4.0	4.0	10	10	10	4.0	4.0
(5) Voltage Drop V _{dr}	(mV)	09	100	22	120	150	09	09	100	150	100	40	09
(4) Voltage Proof VP	(3)	200	125	250	375	125	009	200	125	250	200	250	200
(3) Insulation Resistance Ri (MΩ)	(b) + 125°C	10	10	100	100	10	10	10	10	10	100	10	10
Insulation Resistance Ri (M\O)	(a) - 55°C/ + 85°C	100	100	1000	1000	100	100	100	100	100	1000	100	100
(2) 'oltage (V)	(b) +85°C/ +125°C	20	20	20	100	40	200	200	40	20	200	70	50
Rated Voltage U _R (V)	(a) - 55°C/ + 85°C +	80	20	100	150	50	300	200	20	100	200	100	80
(1) Variant (Note 1)		01, 13, 25, 37	02, 14, 26, 38	03, 15, 27, 39	04, 16, 28, 40	05, 17, 29, 41	06, 18, 30, 42	07, 19, 31, 43	08, 20, 32, 44	09, 21, 33, 45	10, 22, 34, 46	11, 23, 35, 47	12, 24, 36, 48

NOTES

1. See the Table below and Figure 2 for physical characteristics.

VARIANT	CASE THREAD E	LOCK WASHER	CASE FINISH
01 to 12	I: M6×0.75	Fan	Silver plated
13 to 24	I: M6×0.75	Fan	Tin-lead plated
25 to 36	U : ‡ - 28 UNF	Tooth	Silver plated
37 to 48	U: 4 - 28 UNF	Tooth	Tin-lead plated

See Figure 3. ٥į



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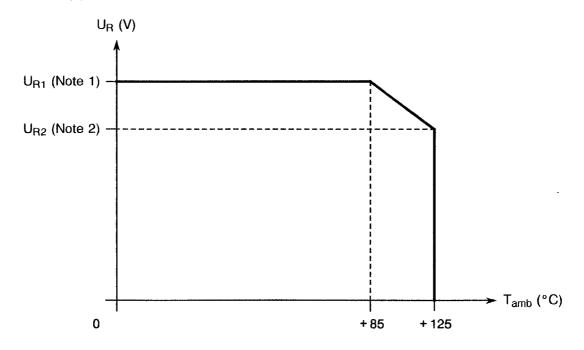
TABLE 1(b) - MAXIMUM RATINGS

No.	Characteristic	Symbol	Maximum Ratings	Unit	Remarks
1	Rated d.c. Voltage	U _R	See Table 1(a) Column 2	V	Notes 1 and 2
2	Voltage Drop	V _{dr}	See Table 1(a) Column 5	mV	
3	d.c. Resistance	Rs	See Table 1(a) Column 6	m Ω	
4	Rated Current	l _R	See Table 1(a) Column 7	, ,A	Note 3
5	Torque	T _{qe}	0.8	Nm	
6	Operating Temperature Range	T _{op}	-55 to +125	°C	T _{amb}
7	Storage Temperature Range	T _{stg}	-55 to +125	°C	
8	Soldering Temperature	T _{sol}	+ 260	°C	Note 4

NOTES

- 1. At $T_{amb} \le +85$ °C. For derating at $T_{amb} > +85$ °C, see Figure 1.
- 2. The addition of d.c. applied voltage and ripple voltage shall never exceed the rated d.c. voltage.
- 3. d.c. and low frequency.
- 4. Duration 10 seconds maximum at a distance of not less than 2.0mm from the device body and the same lead shall not be resoldered until 3 minutes have elapsed.

FIGURE 1 - PARAMETER DERATING INFORMATION



Rated Voltage versus Temperature

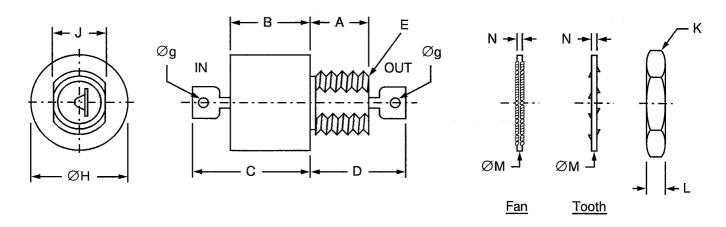
- 1. See UR1 Voltage value for each variant on Table 1(a), Column 2(a).
- 2. See U_{B2} Voltage value for each variant on Table 1(a), Column 2(b).



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FIGURE 2 - PHYSICAL DIMENSIONS

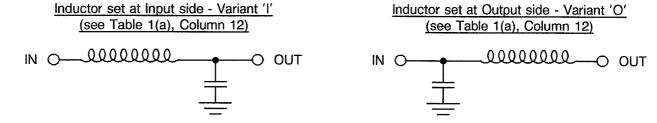


	Case	Size 1	Case	Size 2	Case	Size 3	Case	Size 4	
Symbol	Millim	netres	Millim	netres	Millim	etres	Millim	netres	Notes
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Α	5.10	5.20	5.10	5.20	5.10	5.20	5.10	5.20	
В	4.50	4.80	14.00	14.30	6.50	6.80	5.00	5.30	
С	-	8.80	-	18.30	-	10.80	-	9.40	1
D	_	9.00	-	9.00	-	9.00	-	9.00	2
E	See Tal	See Table 1(a)		ole 1(a)	See Table 1(a)		See Table 1(a)		Thread
Øg	1.5	50	1.8	50	1.8	50	1.5	50	
ØН	9.70	9.90	9.70	9.90	9.70	9.90	9.70	9.90	
J	4.90	5.10	4.90	5.10	4.90	5.10	4.90	5.10	
K	-	8.00	-	8.00	-	8.00	-	8.00	Across flats
L	-	2.50	-	2.50	-	2.50	-	2.50	
Øм	-	9.40	-	9.40	-	9.40	-	9.40	Variants 01 to 24
	-	10.20	-	10.20	-	10.20	-	10.20	Variants 25 to 48
N	-	0.40	-	0.40	-	0.40	-	0.40	Variants 01 to 24
	-	0.60	-	0.60	-	0.60	-	0.60	Variants 25 to 48

NOTES

- 1. Lead finish shall commence not more than 1.5mm from encapsulant.
- 2. The terminals are defined as rigid.

FIGURE 3 - FUNCTIONAL DIAGRAM





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4. **REQUIREMENTS**

4.1 GENERAL

The complete requirements for procurement of the components specified herein are stated in this specification and ESA/SCC Generic Specification No. 3008 for Capacitors and Capacitor Filters, Feedthrough. Deviations from the Generic Specification, applicable to this specification only, are detailed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

4.2 DEVIATIONS FROM GENERIC SPECIFICATION

4.2.1 Deviations from Special In-process Controls

None.

4.2.2 <u>Deviations from Final Production Tests (Chart II)</u>

(a) Para. 9.7, External Visual Inspection: For variants with a silver plated case, a change of shade is acceptable.

4.2.3 Deviations from Burn-in and Electrical Measurements (Chart III)

(a) Para. 9.7, External Visual Inspection: For variants with a silver plated case, a change of shade is acceptable.

4.2.4 Deviations from Qualification Tests (Chart IV)

(a) Para. 9.7, External Visual Inspection: For variants with a silver plated case, a change of shade is acceptable.

4.2.5 Deviations from Lot Acceptance Tests (Chart V)

(a) Para. 9.7, External Visual Inspection: For variants with a silver plated case, a change of shade is acceptable.

4.3 MECHANICAL REQUIREMENTS

4.3.1 Dimension Check

The dimensions of the components specified herein shall be verified in accordance with the requirements set out in Para. 9.5 of ESA/SCC Generic Specification No. 3008 and they shall conform to those shown in Figure 2 of this specification.

4.3.2 Weight

The maximum weight of the components specified herein shall be as given in Table 1(a).

4.3.3 Robustness of Terminations

The requirements for the robustness of terminations tests are specified in Section 9 of ESA/SCC Generic Specification No. 3008. The leads are defined as "Rigid".

- Test Ua1, Tensile : The load shall be 20N.



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4.3.4 Solderability

The requirements for solderability testing are specified in Section 9 of ESA/SCC Generic Specification No. 3008.

Test Method 1 shall apply and a thermal screen of 1.6mm may be used. The terminal shall be immersed up to the terminal slot which shall be fully filled.

4.3.5 Seal Test

The requirements for seal testing are specified in Section 9 of ESA/SCC Generic Specification No. 3008.

The limit for fine leak shall be 5.10⁻³ Pa.cm³/s [5.10⁻⁸ bar.cm³/s].

4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the components specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

4.4.1 Case

The case shall be silver plated or tin-lead plated brass and hermetically sealed with hard glass seals (see Table 1(a)).

4.4.2 Lead Material and Finish

The lead material shall be Type 'G' with Type '3 or 4' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.

4.4.3 **Accessories**

Nut

: As per Figure 2, brass, silver-plated.

Lock-Washer: As per Figure 2, bronze, silver-plated.

4.5 **MARKING**

4.5.1 General

The marking of components delivered to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700 and the following paragraphs. When the component is too small to accommodate all of the marking specified, as much as space permits shall be marked and the marking information, in full, shall accompany the component in its primary package.

The information to be marked and the order of precedence, shall be as follows:-

- (a) Lead Identification.
- (b) The SCC Component Number.
- (c) Traceability Information.



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4.5.2 Lead Identification

Not applicable.

4.5.3 The SCC Component Number

The SCC Component Number shall be constituted and marked as follows:-

	300802901E
Detail Specification Number	
Type Variant (see Table 1(a))	
Testing Level (B or C. as applicable) -	

4.5.4 <u>Traceability Information</u>

Each component shall be marked in respect of traceability information in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

4.6 ELECTRICAL MEASUREMENTS

4.6.1 <u>Electrical Measurements at Room Temperature</u>

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise specified, measurements shall be performed at T_{amb} = +22 ±3 °C.

4.6.2 Electrical Measurements at High and Low Temperatures

The parameters to be measured at high and low temperatures are scheduled in Table 3. Measurements shall be performed at $T_{amb} = 125(+0-5)$ °C and -55(+5-0) °C respectively.

4.6.3 Circuits for Electrical Measurements (Figure 4)

Not applicable.

4.7 BURN-IN TESTS

4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are as specified in Table 4 of this specification. Unless otherwise stated, measurements shall be performed at T_{amb} = +22 ±3 °C. The parameter drift values (Δ) applicable to the parameters scheduled shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit values specified in Table 2 shall not be exceeded.

4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 3008. The conditions for burn-in shall be as specified in Table 5(a) of this specification.

4.7.3 Electrical Circuit for Burn-in (Figure 5)

Not applicable.



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TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE - d.c. PARAMETERS

No.	Characteristics	Symbol ESA/SCC 3008		Test	Lin	Limits		
INO.	Characteristics	Зуньон	Test Method	Conditions	Min	Max	Unit	
1	Voltage Drop	$V_{ m dr}$	Para. 9.4.1.5	I _R = Note 1	-	Note 2	٧	
2	Voltage Proof	VP	Para. 9.4.1.2		Note 3	-	٧	
3	Insulation Resistance	Ri	Para. 9.4.1.3	Para. 9.4.1.3	Note 4	-	МΩ	

NOTES

- 1. See Column 7 of Table 1(a).
- 2. See Column 5 of Table 1(a).
- 3. See Column 4 of Table 1(a).
- 4. See Column 3(a) of Table 1(a).

TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE - a.c. PARAMETERS

No.	Characteristics	Symbol ESA/SCC 3008 Test		Test	Lin	nits	Unit
NO.	Characteristics	Зуппон	Test Method	Conditions	Min	Max	Offic
4	Insertion Loss	I _{L1}	Para. 9.4.1.4	f = 100kHz Note 1	Note 2	- .	dB
5	Insertion Loss	l _{L2}	Para. 9.4.1.4	f = 1.0MHz Note 3	Note 2	-	dB
6	Insertion Loss	I _{L3}	Para. 9.4.1.4	f = 10MHz Note 3	Note 2	-	dB
7	Insertion Loss	l _{L4}	Para. 9.4.1.4	f = 100MHz Note 3	Note 2	-	dB
8	Insertion Loss	I _{L5}	Para. 9.4.1.4	f = 1.0GHz Note 1	Note 2	-	dB
9	Capacitance	С	Para. 9.4.1.1	Para. 9.4.1.1	Note 4	-	μF

- 1. Measurements at this frequency to be made only during Chart IV testing.
- 2. See Column 9 of Table 1(a).
- 3. Measurements at rated current to be made only during Chart IV testing in Subgroups II or III. Measurements without load current to be made during Charts II, III and V.
- 4. See Column 8 of Table 1(a).



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TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

No.	Characteristics	Symbol	ESA/SCC 3008 Test Method	Test Conditions	Lin	Unit	
No.				(Note 1)	Min	Max	Offic
3	Insulation Resistance	Ri	Para. 9.4.1.3	Para. 9.4.1.3 T _{amb} = +125°C (Note 4)	Note 2		МΩ
5	Insertion Loss	l _{L2}	Para. 9.4.1.4	f = 1.0MHz No current.	Note 3	-	dB
6	Insertion Loss	l _{L3}	Para. 9.4.1.4	f = 10MHz No current.	Note 3	-	dB
7	Insertion Loss	I _{L4}	Para. 9.4.1.4	f = 100MHz No current.	Note 3	-	dB

- 1. If more than 20 units have to be measured, the measurement shall be performed on a sample basis in accordance with Inspection Level I, Table IIA, AQL = 1.0% of IEC Publication No. 410.
- 2. See Column 3 of Table 1(a).
- 3. See Column 9 of Table 1(a).
- 4. Insulation Resistance is to be performed only at high temperature.



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FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

Not applicable.

TABLE 4 - PARAMETER DRIFT VALUES

No.	Characteristics	Symbol	Spec. and/or Test Method	Test Conditions	Change Limits (Δ)	Unit
9	Capacitance Change	<u>ΔC</u> C	As per Table 2	As per Table 2	±10	%

TABLE 5(a) - CONDITIONS FOR BURN-IN TESTS

No.	Characteristic	Symbol	Condition	Unit
1	Ambient Temperature	T _{amb}	+ 125(+ 0 - 3)	°C
2	Test Voltage	V _T	2×U _R at +125°C Note 1	V

NOTES

1. Applied between one terminal and the case. See Column 2(b) of Table 1(a) for value of U_R.

TABLE 5(b) - CONDITIONS FOR OPERATING LIFE TESTS

No.	Characteristic	Symbol	Condition	Unit
1	Ambient Temperature	T _{amb}	+ 125(+ 0 - 3)	°C
2	Test Voltage	V _T	2×U _R at +125°C Note 1	٧
3	Rated Current	l _R	Note 2	Α

NOTES

- 1. Applied between one terminal and the case. See Column 2(b) of Table 1(a) for value of U_R.
- 2. To flow between the terminals. See Column 7 of Table 1(a) for value of I_R.

FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN AND OPERATING LIFE TESTS

Not applicable.



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4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC SPECIFICATION No. 3008)</u>

4.8.1 Measurements and Inspections on Completion of Environmental Tests

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.2 Measurements and Inspections at Intermediate Points During Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22 ±3 °C.

4.8.3 <u>Measurements and Inspections on Completion of Endurance Tests</u>

The parameters to be measured and inspections to be performed on completion of endurance testing are as scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22 ±3 °C.

4.8.4 Conditions for Operating Life Tests (Part of Endurance Testing)

The requirements for operating life test are specified in Section 9 of ESA/SCC Generic Specification No. 3008. The conditions for operating life testing shall be as specified in Table 5(b) of this specification.

4.8.5 Electrical Circuit for Operating Life Tests (Figure 5)

Not applicable.



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TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

	ESA/SCC GENERIC SPEC. NO. 3008		MEASUREMENTS	AND INSPECTIONS		LIMITS		
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT
01	Seal Test (Hermetically Sealed)	Para. 9.6 and Para. 4.3.5 of this spec.	Gross Leak Fine Leak	ESA/SCC No. 3008 Para. 9.6.1 ESA/SCC No. 3008 Para. 9.6.2	-	-	-	
02	External Visual Inspection	Para. 9.7 and Paras 4.2.4 and 4.2.5 of this spec.	Final Measurements Visual Inspection	ESA/SCC No. 20500	-	•	-	
03	Temperature Rise	Para. 9.9	Temperature Rise	Rated Current (3)	-	-	25	°C
04	Shock	Para. 9.10	Measurements during Tests	100% U _R (2) applied No Open or Short Circuits >0.1ms		-	-	
			Final Measurements Visual Examination Insertion Loss	No Mechanical Damage Table 2 Items 4 to 8	- ار	Table 2	-	
05	Vibration	Para. 9.11	Measurements during Tests During Last Cycle	Rated Current (3) and 100% U _R (2) applied No Open or Short Circuits > 0.1ms	•	-	-	
			Final Measurements Visual Examination Insertion Loss	No Mechanical Damage Table 2 Items 4 to 8	ار	- Table 2	- -	
06	Accelerated Damp Heat	Before tests, 10 cycles of Para. 9.2 Para. 9.12	Final Measurements Visual Examination Voltage Proof Insulation Resistance	After recovery of 4 to 24 hrs No corrosion or obliteration of marking Table 2 Item 2 Table 2 Item 3	- VP Ri	- 90% U _R (2) (4)	-	
			Insertion Loss	Table 2 Items 4 to 8	IL	Table 2	-	
07	Low Air Pressure	Para. 9.13	Measurements during Tests Voltage Proof	During last 5 minutes Table 2 Item 2	VP	125% U _R (2)	-	
			Visual Examination	No breakdown, flashover, deformation or seepage	-	-	- !	
			Visual Examination	No breakdown, flashover, deformation or seepage	-	-	<u>-</u>	
08	Robustness of Terminations	Para. 9.14 and Para. 4.3.3 of this spec.	Final Measurements Visual Examination Voltage Drop	No damage Table 2 Item 1	- V _{dr}	- -	- Table 2	

- 1. The tests in this Table refer to either Chart IV or V and shall be used as applicable.
- 2. For U_R, see Column 2(a) of Table 1(a).
- 3. For I_R, see Column 7 of Table 1(a).
- 4. Greater than 10% of the value given in Table 2.
- 5. Greater than 50% of the value given in Table 2.



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TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (CONT'D)

	ESA/SCC GENERIC S	SPEC. NO. 3008	MEASUREMENTS /		LIMITS			
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT
09	Immersion	Before tests, 10 cycles of Para. 9.2 Para. 9.15	Final Measurements Visual Examination Voltage Proof Insulation Resistance Insertion Loss	After recovery of 4 to 24 hrs No obliteration of marking and harmful corrosion Table 2 Item 2 Table 2 Item 3 Table 2 Items 4 to 8	VP Ri I	90% U _R (2) (4) Table 2	-	
10	Overload	Para. 9.16	Final Measurements Insulation Resistance Voltage Drop Visual Examination	140% of Rated Current (3) for 15 mins min. Table 2 Item 3 Table 2 Item 1 No damage	Ri V _{dr}	Table 2 - -	- Table 2 -	
11	Resistance to Soldering Heat	Para. 9.17	Final Measurements Visual Examination Insulation Resistance Insertion Loss	After recovery of 1 to 2 hrs No damage Table 2 Item 3 Table 2 Items 4 to 8	- Ri I _L	Table 2 Table 2	- -	
12	Solderability	Para. 9.18 and Para. 4.3.4 of this spec.	Final Measurements Visual Examination	IEC No. 68-2-20 Para. 4.6.4, 4.7.4 or 4.9.3	-	-	-	
13	Operating Life	Para. 9.19	Initial Measurements Capacitance During Tests	Table 2 Item 9 No Open or Short Circuit	C -	Record -	values -	
			Intermediate Measurements Insulation Resistance Voltage Proof	Table 3 Item 3 After 24 hrs recovery Table 2 Item 2	Ri VP	Table 3	-	
			Insulation Resistance Insertion Loss Capacitance Change Final Measurements	Table 2 Item 3 Table 2 Items 4 to 8 Table 2 Item 9	Ri I _L ΔC/C	(2) (5) Table 2	- - Table 4	
			Insulation Resistance Voltage Proof	Table 3 Item 3 After 24 hrs recovery Table 2 Item 2	Ri VP	Table 3 90% U _R (2)	-	
	444.		Insulation Resistance Insertion Loss Capacitance Change	Table 2 Item 3 Table 2 Items 4 to 8 Table 2 Item 9	Ri Ι _L ΔC/C	(5) Table 2	Table 4	
14	Corrosion	Para. 9.20	Final Measurements Visual Examination	No corrosion, damage or obliteration of marking	-	-	-	
15	Permanence of Marking	Para. 9.21	Final Measurements Visual Examination	No corrosion or obliteration of marking	-	-	-	
16	Damp Heat (Non-hermetically Sealed)	Para. 9.24	Not applicable.					

NOTES: See Page 16.



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APPENDIX 'A'

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AGREED DEVIATIONS FOR EUROFARAD (F)

ITEMS AFFECTED	DESCRIPTION OF DEVIATIONS
Paras. 4.2.2 and 4.2.3	(a) Para. 9.4.1.5, Voltage Drop: Voltage Drop may be performed as a d.c. Resistance measurement in accordance with MIL-STD-202, Method 303. In this case, the maximum value of d.c. Resistance (Rs) shall be as specified in Column 6 of Table 1(a).